MOSFET – N-Channel, Field Effect Transistor, Enhancement Mode

NDP6060 / NDB6060

V_{DSS}	$R_{DS(ON)}$ MAX	I_D MAX
60 V	0.025 mΩ @ 10 V	48 A

N–CHANNEL MOSFET

TO–220–3LD
CASE 340AT

General Description

These N−Channel enhancement mode power field effect transistors are produced using **onsemi**'s proprietary, high cell density, DMOS technology. This very high density process has been especially tailored to minimize on−state resistance, provide superior switching performance, and withstand high energy pulses in the avalanche and commutation modes. These devices are particularly suited for low voltage applications such as automotive, DC/DC converters, PWM motor controls, and other battery powered circuits where fast switching, low in−line power loss, and resistance to transients are needed.
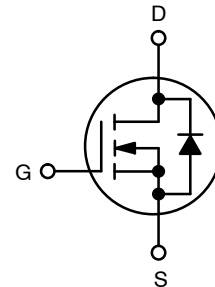
Features

- 48 A, 60 V
  - ♦ $R_{DS(ON)}$ = 0.025 mΩ @ V_{GS} = 10 V
- Critical DC Electrical Parameters Specified at Elevated Temperature
- Rugged Internal Source−Drain Diode Can Eliminate the Need for an External Zener Diode Transient Suppressor
- 175°C Maximum Junction Temperature Rating
- High Density Cell Design for Extremely Low $R_{DS(ON)}$
- TO−220 Package for Both Through Hole and Surface Mount Applications
- This is a Halide Free Device

MARKING DIAGRAM

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XXXXX
XXXXX
AYWWZZ
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XXXX = Specific Device Code
A   = Assembly Location
Y   = Year
WW   = Work Week
ZZ   = Assembly Lot Code

ORDERING INFORMATION

Device	Package	Shipping[†]
NDP6060	TO−220−3LD (Halide Free)	800 / Units / Tube

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

MAXIMUM RATINGS (T_C = 25°C unless otherwise noted)

Symbol	Rating	NDP6060	Unit
V_{DSS}	Drain−Source Voltage	60	V
V_{DGR}	Drain−Gate Voltage ($R_{GS} \leq 1$ MΩ)	60	V
V_{GSS}	Drain−Source Voltage – Continuous – Nonrepetiti (t_p < 50 μs)	±20 ±40	V
I_D	Drain Current – Continuous T_C = 25°C – Continuous T_C = 100°C – Pulsed	48 32 144	A
P_D	Total Power Dissipatiion @ T_C = 25°C – Derate above 25°C	100	W
		0.67	W/°C
T_J, T_{STG}	Operating and Storage Temperature Range	−65 to 175	°C
T_L	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	275	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Symbol	Parameter	Condition		Min	Typ	Max	Unit
DRAIN–SOURCE AVALANCHE RATINGS (Note 1)							
W_{DSS}	Single Pulse Drain–Source Avalanche Energy	V_{DD} = 25 V, I_D = 48 A		–	–	200	mJ
I_{AR}	Maximum Drain–Source Avalanche Current			–	–	48	A
OFF CHARACTERISTICS							
BV_{DSS}	Drain–Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 μA		60	–	–	V
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 60 V, V_{GS} = 0 V		–	–	250	μA
			T_J = 125°C	–	–	1	mA
I_{GSSF}	Gate–Body Leakage, Forward	V_{GS} = 20 V, V_{DS} = 0 V		–	–	100	nA
I_{GSSR}	Gate–Body Leakage, Reverse	V_{GS} = –20 V, V_{DS} = 0 V		–	–	–100	nA
ON CHARACTERISTICS (Note 1)							
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 μA		2	2.9	4	V
			T_J = 125°C	1.4	2.3	3.6	
$R_{DS(ON)}$	Static Drain–Source On–Resistance	V_{GS} = 10 V, I_D = 24 A		–	0.02	0.025	W
			T_J = 125°C	–	0.032	0.04	
$I_{D(on)}$	On–State Drain Current	V_{GS} = 10 V, V_{DS} = 10 V		48	–	–	A
g_{FS}	Forward Transconductance	V_{DS} = 10 V, I_D = 24 A		10	19	–	S
DYNAMIC CHARACTERISTICS							
C_{iss}	Input Capacitance	V_{DS} = 25 V, V_{GS} = 0 V, f = 1.0 MHz		–	1190	1800	pF
C_{oss}	Output Capacitance			–	475	800	pF
C_{rss}	Reverse Transfer Capacitance			–	150	400	pF
SWITCHING CHARACTERISTICS (Note 1)							
$t_{D(on)}$	Turn – On Delay Time	V_{DD} = 30 V, I_D = 48 A, V_{GS} = 10 V, R_{GEN} = 7.5 W		–	10	20	nS
t_r	Turn – On Rise Time			–	145	300	nS
$t_{D(off)}$	Turn – Off Delay Time			–	28	60	nS
tf	Turn – Off Fall Time			–	77	150	nS
Q_g	Total Gate Charge	V_{DS} = 48 V, I_D = 48 A, V_{GS} = 10V		–	39	70	nC
Q_{gs}	Gate–Source Charge			–	7.6	–	nC
Q_{gd}	Gate–Drain Charge			–	22	–	nC
DRAIN–SOURCE DIODE CHARACTERISTICS							
I_S	Maximum Continuos Drain–Source Diode Forward Current			–	–	48	A
I_{SM}	Maximum Pulsed Drain–Source Diode Forward Current			–	–	144	A
V_{SD}	Drain–Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 24 A (Note 1)		–	0.9	1.3	V
			T_J = 125°C	–	0.8	1.2	
t_{rr}	Reverse Recovery Time	V_{GS} = 0 V, I_F = 48 A, dI_F/dt = 100 A/μs		35	87	140	ns
I_{rr}	Reverse Recovery Current			2	3.6	8	A
THERMAL CHARACTERISTICS							
$R_{\theta JC}$	Thermal Resistance, Junction–to–Case			–	–	1.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction–to–Ambient			–	–	62.5	°C/W

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.
1. Pulse Test: pulse width ≤ 300 μs, duty cycle ≤ 2%.

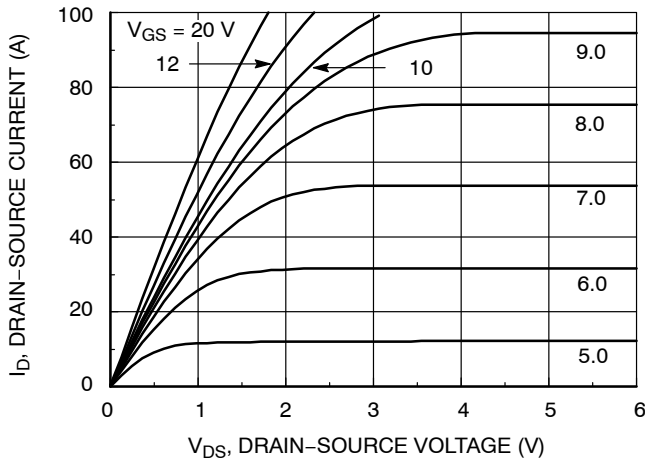# NDP6060 / NDB6060

TYPICAL CHARACTERISTICS
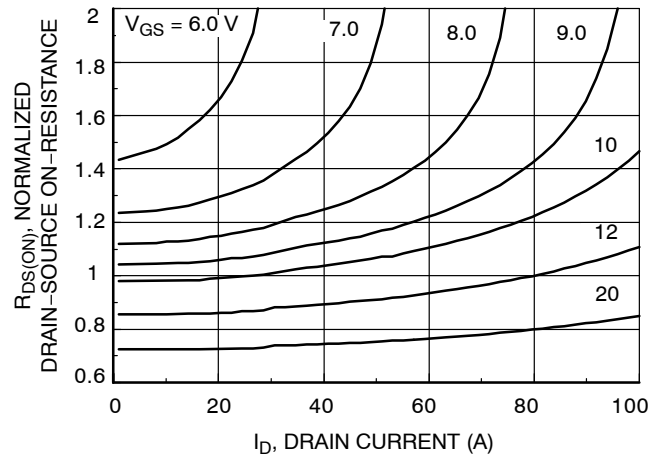
Figure 1. On−Region Characteristics

Figure 2. On−Resistance Variation with Gate Voltage and Drain Current
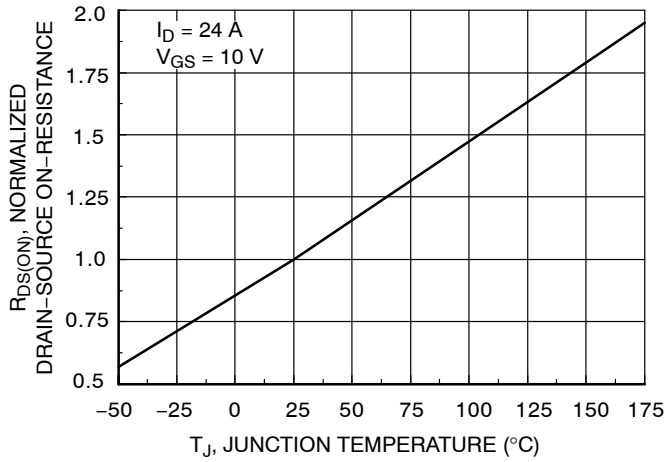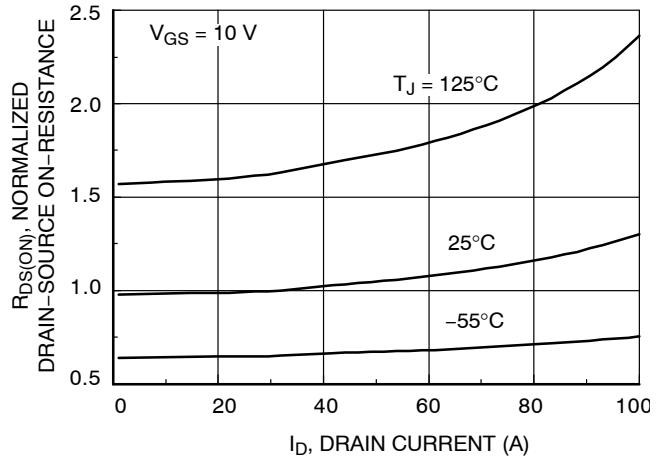
Figure 3. On−Resistance Variation with Temperature

Figure 4. On−Resistance Variation with Drain Current and Temperature
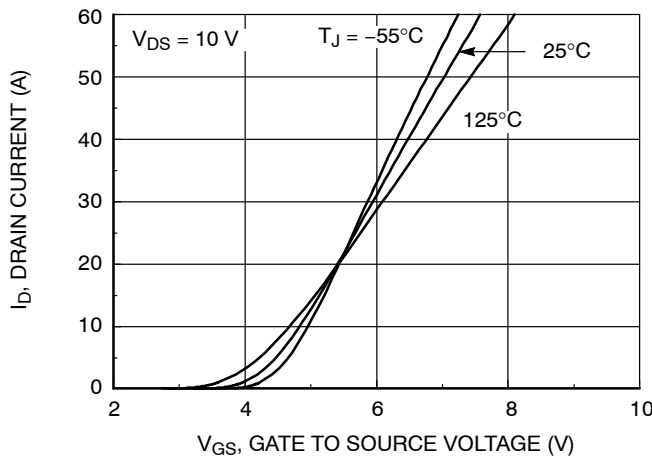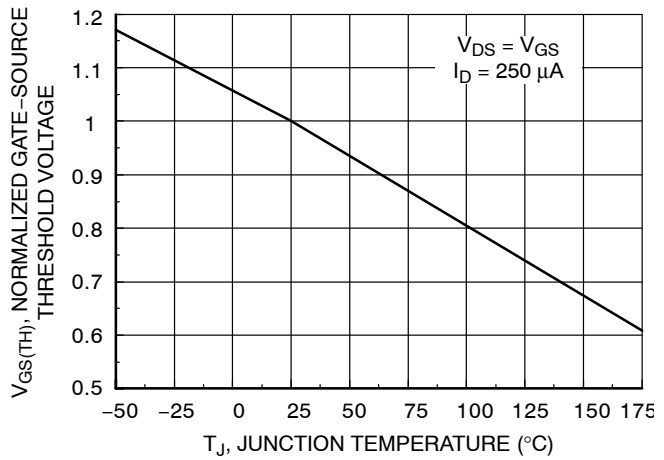
Figure 5. Transfer Characteristics

Figure 6. Gate Threshold Variation with Temperature
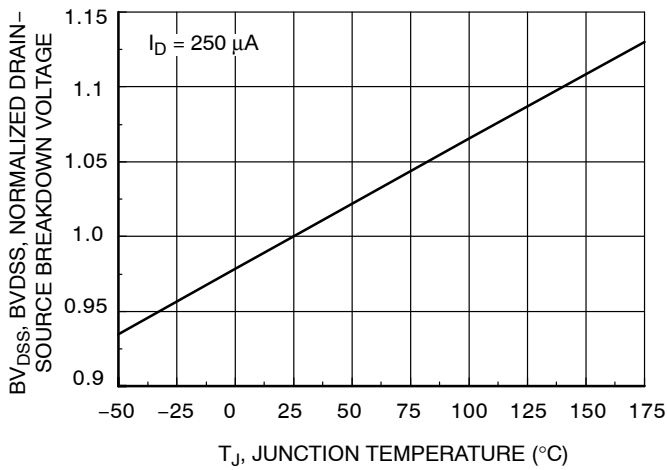
TYPICAL CHARACTERISTICS (continued)
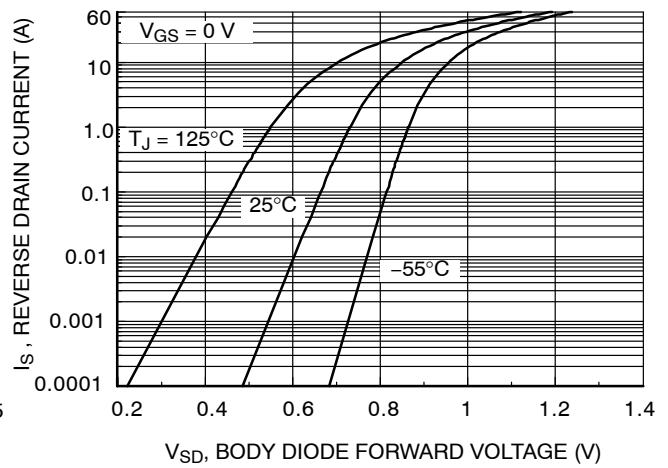

Figure 7. Breakdown Voltage Variation with Temperature

Figure 8. Body Diode Forward Voltage Variation with Current and Temperature
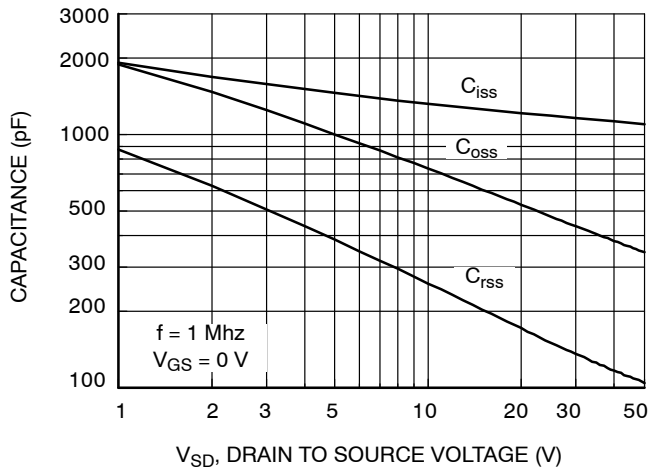
Figure 9. Capacitance Characteristics
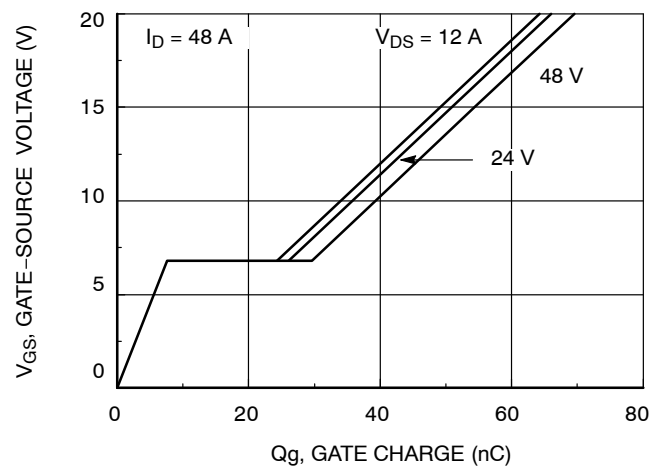
Figure 10. Gate Charge Chracteristics
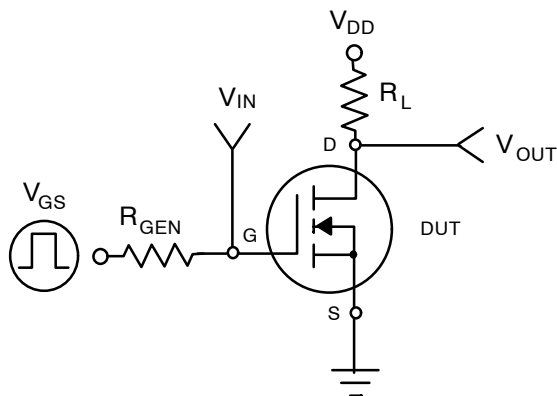
Figure 11. Switching Test Circuit
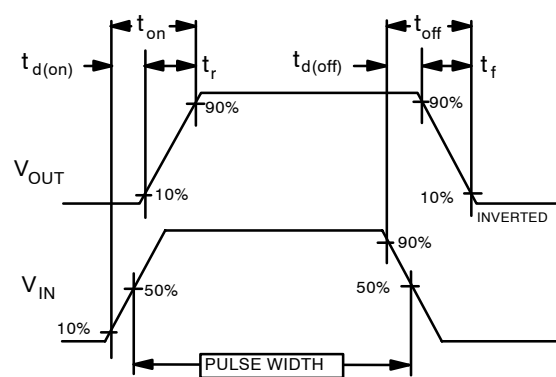
Figure 12. Switching Waveforms

TYPICAL CHARACTERISTICS
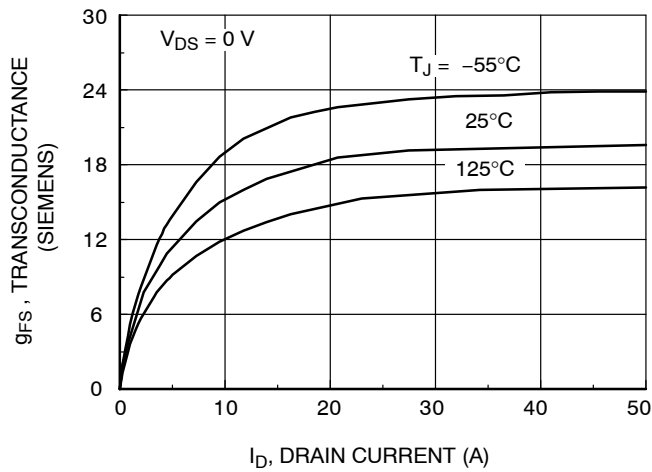
Figure 13. Transconductance Variation with Drain Current and Temperature
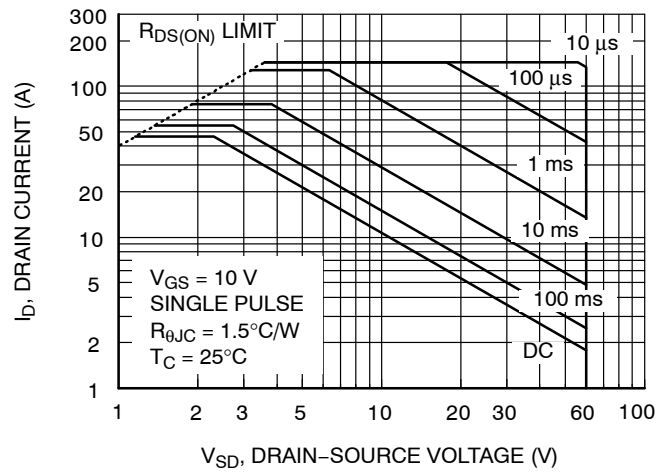
Figure 14. Maximum Safe Operating Area
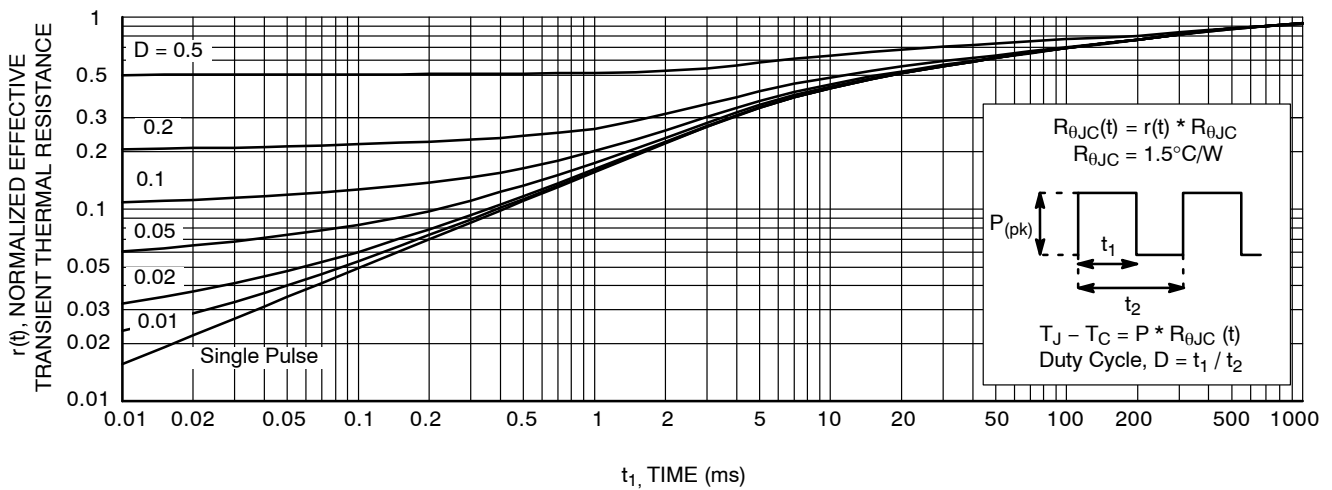
Figure 15. Transient Thermal Response Curve

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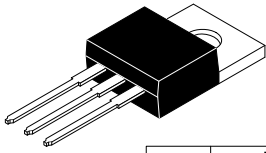
TO−220−3LD
CASE 340AT
ISSUE B

DATE 08 AUG 2022

DIM	MILLIMETERS		
	MIN.	NOM.	MAX.
A	4.00	--	4.70
A1	SEE NOTE "F"		
A2	2.10	--	2.85
b	0.55	--	1.00
b2	1.10	--	1.62
b4	1.42	--	1.62
c	0.36	--	0.60
D	13.90	--	16.30
D1	8.13	--	9.40
D2	11.50	--	14.30
D3	15.42	--	16.51
E	9.65	--	10.67
E1	7.59	--	8.65
e	2.40	--	2.67
H1	6.06	--	6.69
L	12.70	--	14.04
L1	2.70	--	4.10
P	3.50	--	4.00
Q	2.50	--	3.40
z	2.13 REF		
z1	2.06 REF		
Θ	3°	−	5°

SUPPLIER "A" PACKAGE SHAPE

SUPPLIER "B" PACKAGE SHAPE

IF PRESENT, SEE NOTE "D"

FRONT VIEWS

GENERIC MARKING DIAGRAM*
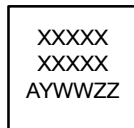
XXXXX
XXXXX
AYWWZZ

XXXX = Specific Device Code
A   = Assembly Location
Y   = Year
WW   = Work Week
ZZ   = Assembly Lot Code

*This information is generic. Please refer to device data sheet for actual part marking. Pb−Free indicator, "G" or microdot "▪", may or may not be present. Some products may not follow the Generic Marking.

"A1" SEE NOTE "F"

OPTIONAL CHAMFER

NOTE "H"

SIDE VIEW

BACK VIEW

BOTTOM VIEW
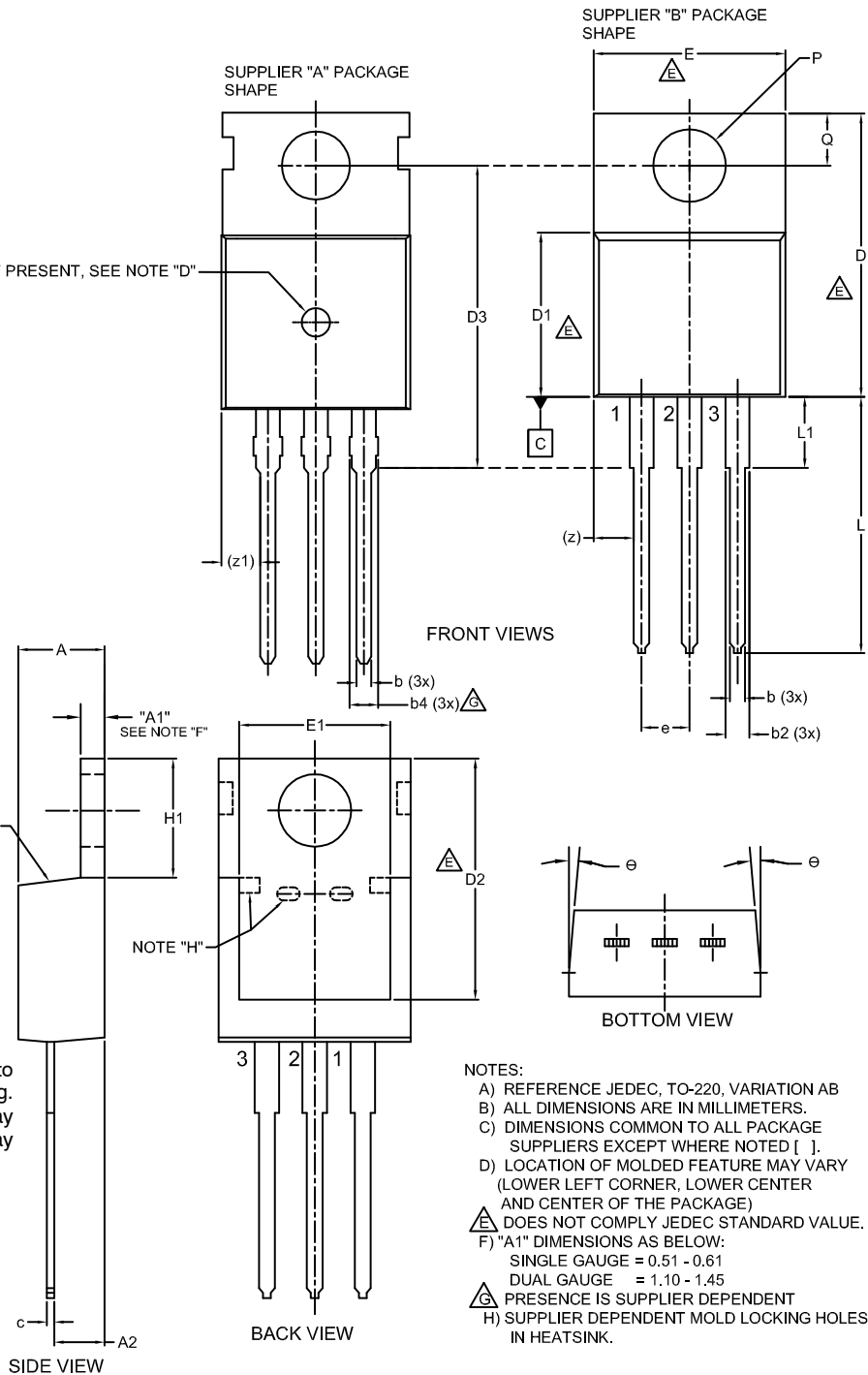
NOTES:
A) REFERENCE JEDEC, TO−220, VARIATION AB
B) ALL DIMENSIONS ARE IN MILLIMETERS.
C) DIMENSIONS COMMON TO ALL PACKAGE SUPPLIERS EXCEPT WHERE NOTED [ ].
D) LOCATION OF MOLDED FEATURE MAY VARY (LOWER LEFT CORNER, LOWER CENTER AND CENTER OF THE PACKAGE)
E) DOES NOT COMPLY JEDEC STANDARD VALUE.
F) "A1" DIMENSIONS AS BELOW:
   SINGLE GAUGE = 0.51 - 0.61
   DUAL GAUGE   = 1.10 - 1.45
G) PRESENCE IS SUPPLIER DEPENDENT
H) SUPPLIER DEPENDENT MOLD LOCKING HOLES IN HEATSINK.

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DESCRIPTION:	**TO−220−3LD**		**PAGE 1 OF 1**

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